74HC2G126; 74HCT2G126

Dual buffer/line driver; 3-state

Rev. 5 — 18 December 2013

Product data sheet

1. General description

The 74HC2G126; 74HCT2G126 is a dual buffer/line driver with 3-state outputs controlled by the output enable inputs (nOE). Inputs include clamp diodes. This enables the use of current limiting resistors to interface inputs to voltages in excess of V_{CC} .

2. Features and benefits

- Wide operating voltage from 2.0 V to 6.0 V
- Input levels:
 - ◆ For 74HC2G126: CMOS level
 - ♦ For 74HCT2G126: TTL level
- Complies with JEDEC standard no. 7A
- Symmetrical output impedance
- High noise immunity
- Low power dissipation
- Balanced propagation delays
- ESD protection:
 - ◆ HBM JESD22-A114F exceeds 2000 V
 - ♦ MM JESD22-A115-A exceeds 200 V
- Multiple package options
- Specified from -40 °C to +85 °C and -40 °C to +125 °C

3. Ordering information

Table 1. Ordering information

Type number	Package								
	Temperature range	Name	Description	Version					
74HC2G126DP	-40 °C to +125 °C	TSSOP8	plastic thin shrink small outline package; 8 leads;	SOT505-2					
74HCT2G126DP			body width 3 mm; lead length 0.5 mm						
74HC2G126DC	-40 °C to +125 °C	VSSOP8	plastic very thin shrink small outline package; 8 leads;	; SOT765-1					
74HCT2G126DC			body width 2.3 mm						
74HC2G126GD	-40 °C to +125 °C	XSON8	plastic extremely thin small outline package; no leads;	SOT996-2					
74HCT2G126GD			8 terminals; body $3 \times 2 \times 0.5$ mm						



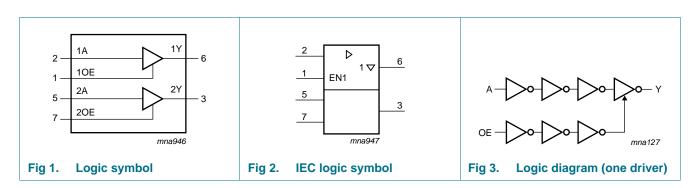
4. Marking

Table 2. Marking codes[1]

Type number	Marking code
74HC2G126DP	H26
74HCT2G126DP	T26
74HC2G126DC	H26
74HCT2G126DC	T26
74HC2G126GD	H26
74HCT2G126GD	T26

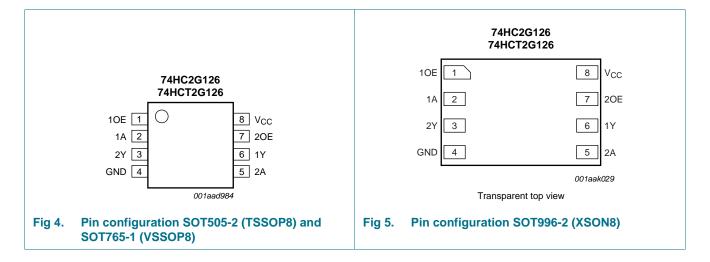
^[1] The pin 1 indicator is located on the lower left corner of the device, below the marking code.

5. Functional diagram



6. Pinning information

6.1 Pinning



6.2 Pin description

Table 3. Pin description

Symbol	Pin	Description
10E, 20E	1, 7	output enable input
1A, 2A	2, 5	data input
1Y, 2Y	6, 3	data output
GND	4	ground (0 V)
V _{CC}	8	supply voltage

7. Functional description

Table 4. Function table[1]

Input nOE	Output	
nOE	nA	nY
Н	L	L
Н	Н	Н
L	X	Z

^[1] H = HIGH voltage level; L = LOW voltage level; X = don't care; Z = high-impedance OFF-state.

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

		3 , , , , , , , , , , , , , , , , , , ,		.0	,
Symbol	Parameter	Conditions	Min	Max	Unit
V_{CC}	supply voltage		-0.5	+7.0	V
I _{IK}	input clamping current	$V_I < -0.5 \text{ V or } V_I > V_{CC} + 0.5 \text{ V}$	<u>[1]</u> _	±20	mA
I _{OK}	output clamping current	$V_O < -0.5 \text{ V or } V_O > V_{CC} + 0.5 \text{ V}$	<u>[1]</u> _	±20	mA
Io	output current	$V_{O} = -0.5 \text{ V to } (V_{CC} + 0.5 \text{ V})$	<u>[1]</u> _	±35	mA
I _{CC}	supply current		-	70	mA
I _{GND}	ground current		-70	-	mA
T _{stg}	storage temperature		-65	+150	°C
P _{tot}	total power dissipation		[2] -	300	mW

^[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

^[2] For TSSOP8 package: above 55 °C the value of P_{tot} derates linearly with 2.5 mW/K. For VSSOP8 package: above 110 °C the value of P_{tot} derates linearly with 8 mW/K. For XSON8 package: above 118 °C the value of P_{tot} derates linearly with 7.8 mW/K.

9. Recommended operating conditions

Table 6. Recommended operating conditions

Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter Conditions		74HC2G126			74HCT2G126			Unit
			Min	Тур	Max	Min	Тур	Max	
V_{CC}	supply voltage		2.0	5.0	6.0	4.5	5.0	5.5	V
VI	input voltage		0	-	V_{CC}	0	-	V_{CC}	V
Vo	output voltage		0	-	V_{CC}	0	-	V_{CC}	V
T _{amb}	ambient temperature		-40	+25	+125	-40	+25	+125	°C
Δt/ΔV	input transition rise	$V_{CC} = 2.0 \text{ V}$	-	-	625	-	-	-	ns/V
,	and fall rate	V _{CC} = 4.5 V	-	1.67	139	-	1.67	139	ns/V
		V _{CC} = 6.0 V	-	-	83	-	-	-	ns/V

10. Static characteristics

Table 7. Static characteristics

Voltages are referenced to GND (ground = 0 V). All typical values are measured at T_{amb} = 25 °C.

Symbol	Parameter	Conditions	T _{amb} =	–40 °C to	+85 °C	$T_{amb} = -40$ °	Unit	
			Min	Тур	Max	Min	Max	
74HC2G1	26			•	•	'		
V_{IH}	HIGH-level input	V _{CC} = 2.0 V	1.5	1.2	-	1.5	-	V
	voltage	V _{CC} = 4.5 V	3.15	2.4	-	3.15	-	V
		V _{CC} = 6.0 V	4.2	3.2	-	4.2	-	V
V_{IL}	LOW-level input voltage	V _{CC} = 2.0 V	-	0.8	0.5	-	0.5	V
		V _{CC} = 4.5 V	-	2.1	1.35	-	1.35	V
		V _{CC} = 6.0 V	-	2.8	1.8	-	1.8	V
V_{OH}	HIGH-level output voltage	$V_I = V_{IH}$ or V_{IL}						
		$I_O = -20 \mu A$; $V_{CC} = 2.0 V$	1.9	2.0	-	1.9	-	V
		$I_O = -20 \mu A$; $V_{CC} = 4.5 V$	4.4	4.5	-	4.4	-	V
		$I_O = -20 \mu A$; $V_{CC} = 6.0 \text{ V}$	5.9	6.0	-	5.9	-	V
		$I_O = -6.0 \text{ mA}$; $V_{CC} = 4.5 \text{ V}$	3.84	4.32	-	3.7	-	V
		$I_{O} = -7.8 \text{ mA}; V_{CC} = 6.0 \text{ V}$	5.34	5.81	-	5.2	-	V
V_{OL}	LOW-level output	$V_I = V_{IH}$ or V_{IL}						
	voltage	I_{O} = 20 μ A; V_{CC} = 2.0 V	-	0	0.1	-	0.1	V
		$I_O = 20 \mu A; V_{CC} = 4.5 V$	-	0	0.1	-	0.1	V
		$I_O = 20 \mu A; V_{CC} = 6.0 V$	-	0	0.1	-	0.1	V
		$I_{O} = 6.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	-	0.15	0.33	-	0.4	V
		$I_{O} = 7.8 \text{ mA}; V_{CC} = 6.0 \text{ V}$	-	0.16	0.33	-	0.4	V
II	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 6.0 \text{ V}$	-	-	±1.0	-	±1.0	μΑ
l _{OZ}	OFF-state output current	$V_I = V_{IH}$ or V_{IL} ; $V_O = V_{CC}$ or GND; $V_{CC} = 6.0 \text{ V}$	-	-	±5.0	-	±10	μΑ

 Table 7.
 Static characteristics ...continued

Voltages are referenced to GND (ground = 0 V). All typical values are measured at T_{amb} = 25 °C.

Symbol	Parameter	Conditions	T _{amb} =	–40 °C to	+85 °C	T _{amb} = -40 °	Unit	
			Min	Тур	Max	Min	Max	
I _{CC}	supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 6.0 \text{ V}$	-	-	10	-	20	μΑ
Cı	input capacitance		-	1.0	-	-	-	pF
Co	output capacitance		-	1.5	-	-	-	pF
74HCT2G	126							
V_{IH}	HIGH-level input voltage	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	2.0	1.6	-	2.0	-	V
V_{IL}	LOW-level input voltage	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	-	1.2	0.8	-	0.8	V
V _{OH}	HIGH-level	$V_I = V_{IH}$ or V_{IL} ; $V_{CC} = 4.5 \text{ V}$						
	output voltage	I _O = -20 μA	4.4	4.5	-	4.4	-	V
		$I_{O} = -6.0 \text{ mA}$	3.84	4.32	-	3.7	-	V
V_{OL}	LOW-level output voltage	$V_I = V_{IH}$ or V_{IL} ; $V_{CC} = 4.5 \text{ V}$						
		I _O = 20 μA	-	0	0.1	-	0.1	V
		$I_0 = 6.0 \text{ mA}$	-	0.16	0.33	-	0.4	V
I _I	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 5.5 \text{ V}$	-	-	±1.0	-	±1.0	μΑ
l _{OZ}	OFF-state output current	$V_I = V_{IH}$ or V_{IL} ; $V_O = V_{CC}$ or GND; $V_{CC} = 5.5 \text{ V}$	-	-	±5.0	-	±10	
I _{CC}	supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 5.5 \text{ V}$	-	-	10	-	20	μΑ
ΔI_{CC}	additional supply current	per input; $V_{CC} = 4.5 \text{ V}$ to 5.5 V; $V_I = V_{CC} - 2.1 \text{ V}$; $I_O = 0 \text{ A}$	-	-	375	-	410	μΑ
Cı	input capacitance		-	1.0	-	-	-	pF
Co	output capacitance		-	1.5	-	-	-	pF

11. Dynamic characteristics

Table 8. Dynamic characteristics

Voltages are referenced to GND (ground = 0 V); $C_L = 50 \text{ pF}$ unless otherwise specified; for test circuit see Figure 8.

Symbol	Parameter	Conditions		T _{amb} =	–40 °C to	+85 °C	$T_{amb} = -40$	Unit		
				Min	Typ[1]	Max	Min	Max		
74HC2G126										
t _{pd}	propagation delay	nA to nY; see Figure 6	[2]							
		delay	V _{CC} = 2.0 V		-	35	115	-	135	ns
			V _{CC} = 4.5 V		-	11	23	-	27	ns
		$V_{CC} = 5.0 \text{ V}; C_L = 15 \text{ pF}$		-	10	-	-	-	ns	
		$V_{CC} = 6.0 \text{ V}$		-	8	20	-	23	ns	

 Table 8.
 Dynamic characteristics ...continued

Voltages are referenced to GND (ground = 0 V); $C_L = 50 \ pF$ unless otherwise specified; for test circuit see Figure 8.

Symbol	Parameter	Conditions		T _{amb} =	-40 °C to	+85 °C	$T_{amb} = -40^{\circ}$	Unit	
				Min	Typ[1]	Max	Min	Max	
t _{en}	enable time	nOE to nY; see Figure 7	[2]	•			'	•	
		V _{CC} = 2.0 V		-	40	115	-	135	ns
		V _{CC} = 4.5 V		-	11	23	-	27	ns
		V _{CC} = 6.0 V		-	8	20	-	23	ns
t _{dis}	disable time	nOE to nY; see Figure 7	[2]						
		V _{CC} = 2.0 V		-	25	125	-	150	ns
		V _{CC} = 4.5 V		-	12	25	-	30	ns
		V _{CC} = 6.0 V		-	10	21	-	26	ns
t _t transition time	transition	nY; see Figure 6	[2]						
	time	V _{CC} = 2.0 V		-	18	75	-	90	ns
		V _{CC} = 4.5 V		-	6	15	-	18	ns
		$V_{CC} = 6.0 \text{ V}$		-	5	13	-	15	ns
C_{PD}	power dissipation capacitance	per buffer; $V_I = GND$ to V_{CC}	[3]						
		output enabled		-	11	-	-	-	pF
	capacitance	output disabled		-	1	-	-	-	pF
74HCT20	G126								
t _{pd}	propagation	nA to nY; see Figure 6	[2]						
	delay	V _{CC} = 4.5 V		-	15	30	-	36	ns
		$V_{CC} = 5.0 \text{ V}; C_L = 15 \text{ pF}$		-	12	-	-	-	ns
t _{en}	enable time	nOE to nY; see Figure 7; $V_{CC} = 4.5 \text{ V}$	[2]	-	11	31	-	38	ns
t _{dis}	disable time	nOE to nY; see Figure 7; $V_{CC} = 4.5 \text{ V}$	[2]	-	11	35	-	42	ns
t _t	transition time	nY; see <u>Figure 6</u> ; V _{CC} = 4.5 V	[2]	-	6	15	-	18	ns
C_{PD}	power dissipation	per buffer; $V_I = GND$ to $V_{CC} - 1.5 V$	[3]						
	capacitance	output enabled		-	11	-	-	-	pF
		output disabled		-	1	-	-	-	pF

- [1] All typical values are measured at T_{amb} = 25 °C.
- [2] t_{pd} is the same as t_{PLH} and t_{PHL} .
 - t_{en} is the same as t_{PZL} and t_{PZH} .
 - t_{dis} is the same as t_{PLZ} and $t_{\text{PHZ}}.$
 - t_{t} is the same as t_{THL} and $t_{TLH}. \label{eq:tt}$
- [3] C_{PD} is used to determine the dynamic power dissipation (P_D in μW).
 - $P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \Sigma (C_L \times V_{CC}^2 \times f_o) \text{ where:}$
 - f_i = input frequency in MHz;
 - f_o = output frequency in MHz;
 - C_L = output load capacitance in pF;
 - V_{CC} = supply voltage in V;
 - N = number of inputs switching;
 - $\Sigma(C_L \times V_{CC}^2 \times f_o)$ = sum of outputs.

74HC_HCT2G126

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12. Waveforms

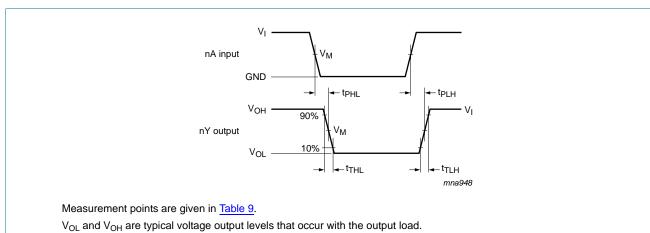
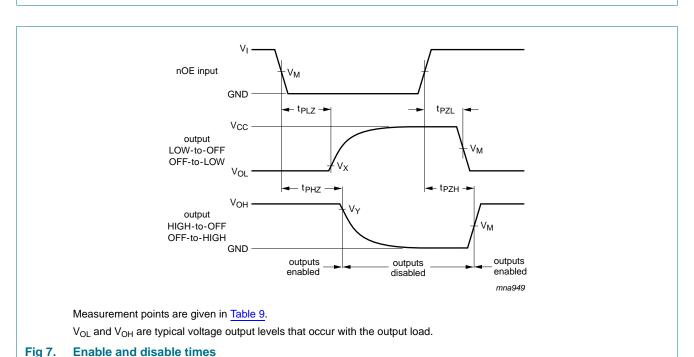


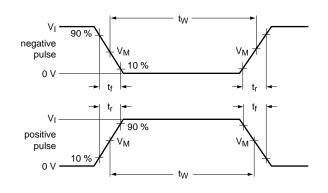
Fig 6. Propagation delay input (nA) to output (nY) and transition time output (nY)

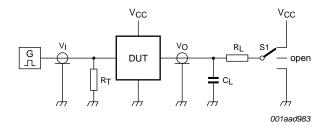


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Table 9. Measurement points

Туре	Input	Output					
	V _M	V _M	V _X	V _Y			
74HC2G126	0.5V _{CC}	0.5V _{CC}	V _{OL} + 0.3 V	$V_{OH} - 0.3 V$			
74HCT2G126	1.3 V	1.3 V	V _{OL} + 0.3 V	V _{OH} – 0.3 V			





Test data is given in Table 10.

Definitions test circuit:

 R_T = Termination resistance should be equal to output impedance Z_o of the pulse generator.

 C_L = Load capacitance including jig and probe capacitance.

R_L = Load resistance.

S1 = Test selection switch.

Fig 8. Test circuit for measuring switching times

Table 10. Test data

Туре	Input		Load		S1 position		
	VI	t _r , t _f	CL	R_L	t _{PHL} , t _{PLH}	t _{PZH} , t _{PHZ}	t_{PZL} , t_{PLZ}
74HC2G126	GND to V_{CC}	≤ 6 ns	15 pF, 50 pF	1 k Ω	open	GND	V _{CC}
74HCT2G126	GND to 3 V	≤ 6 ns	15 pF, 50 pF	1 kΩ	open	GND	V _{CC}

13. Package outline

TSSOP8: plastic thin shrink small outline package; 8 leads; body width 3 mm; lead length 0.5 mm SOT505-2

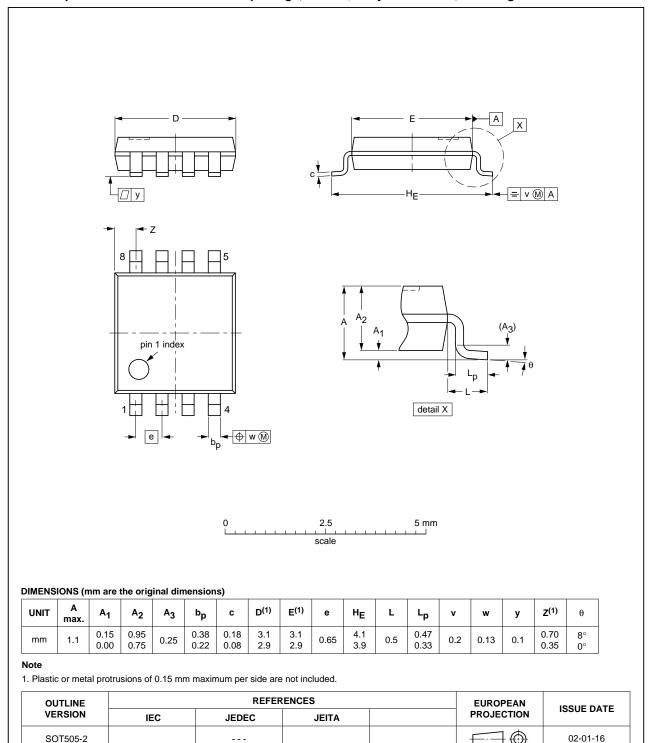
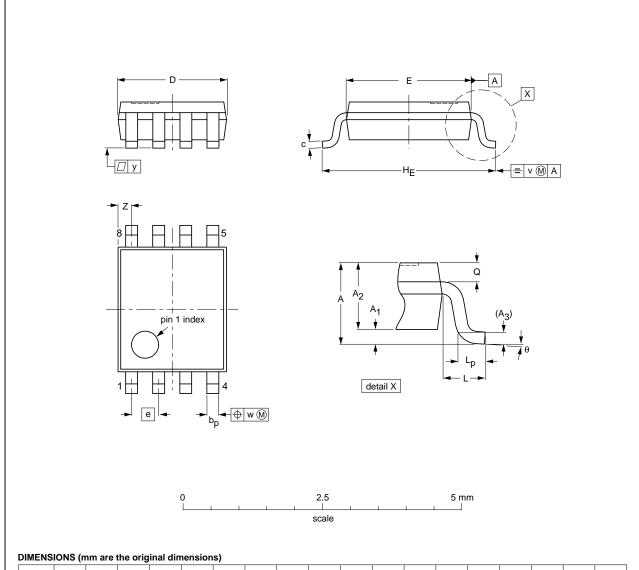


Fig 9. Package outline SOT505-2 (TSSOP8)

9 of 15

VSSOP8: plastic very thin shrink small outline package; 8 leads; body width 2.3 mm

SOT765-1



UNIT	A max.	A ₁	A ₂	А3	bp	С	D ⁽¹⁾	E ⁽²⁾	е	HE	L	Lр	Q	v	w	у	Z ⁽¹⁾	θ
mm	1	0.15 0.00	0.85 0.60	0.12	0.27 0.17	0.23 0.08	2.1 1.9	2.4 2.2	0.5	3.2 3.0	0.4	0.40 0.15	0.21 0.19	0.2	0.13	0.1	0.4 0.1	8° 0°

Notes

- Plastic or metal protrusions of 0.15 mm maximum per side are not included.
 Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	JEITA		PROJECTION	1330E DATE	
SOT765-1		MO-187				02-06-07	

Fig 10. Package outline SOT765-1 (VSSOP8)

74HC_HCT2G126

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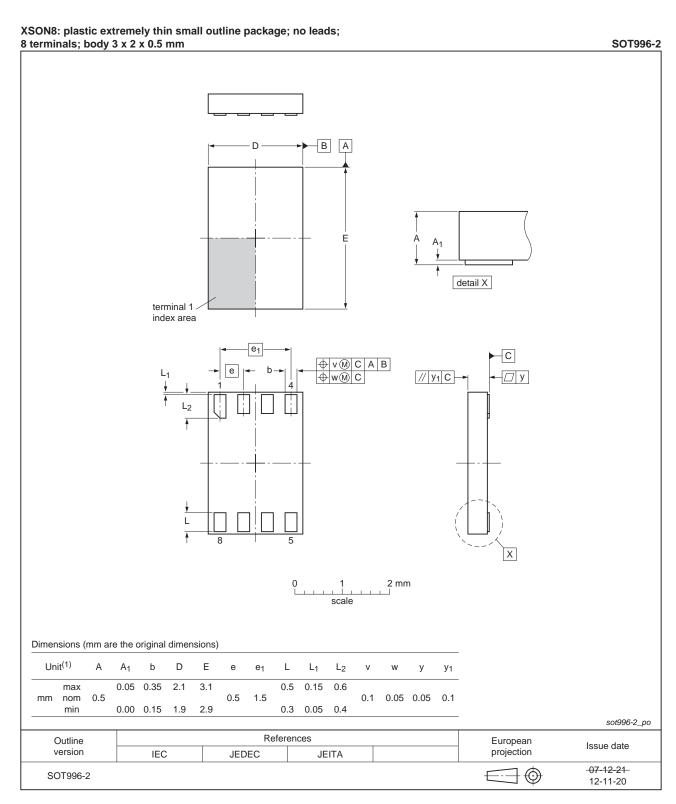


Fig 11. Package outline SOT996-2 (XSON8)

74HC_HCT2G126

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14. Abbreviations

Table 11. Abbreviations

Acronym	Description
CMOS	Complementary Metal Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
НВМ	Human Body Model
MM	Machine Model

15. Revision history

Table 12. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74HC_HCT2G126 v.5	20131218	Product data sheet	-	74HC_HCT2G126 v.4
Modifications:	 For type nun 	nbers 74HC2G126GD and 74	HCT2G126GD XSON	8U has changed to XSON8.
74HC_HCT2G126 v.4	20090924	Product data sheet	-	74HC_HCT2G126 v.3
Modifications:	• <u>Table 2</u> : Mar	king codes table added.		
74HC_HCT2G126 v.3	20090507	Product data sheet	-	74HC_HCT2G126 v.2
74HC_HCT2G126 v.2	20051215	Product data sheet	-	74HC_HCT2G126 v.1
74HC_HCT2G126 v.1	20030303	Product data sheet	-	-

16. Legal information

16.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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